DELIVERY SPECIFICA	SPEC. No. C-Soft-i DATE: Oct., 2023					
		Non-Con	trolled Cop			
CUSTOMER'S PRODUCT NAME	Bulk and Tape pa C1005,C1608,C20	AME RAMIC CHIP CAPACITO ckaging 【RoHS2 comp)12,C3216,C3225,C453 'S,X7T,X8R,X8L Charac	liant】 2,C5750,C7563 Type			
Please return this specification to TDK If orders are placed without returned s accepted by your side. RECEIPT CONFIRMAT	pecification, pleas		at specification is			
	DATE:	YEAR N	IONTH DAY			
TDK Corporation Sales Electronic Components Sales & Marketing Group		ponents Business Com itors Business Group	pany			
APPROVED Person in charge	APPROVED	CHECKED	Person in charge			

SCOPE

This delivery specification shall be applied to Multilayer ceramic chip capacitors(Soft Termination Electrode) to be delivered to _____.

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be $\underline{C} \diamond \diamond \diamond OOO \triangle \triangle \Box \Box \Box \times \otimes \times \times S$.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-21:2014	Fixed capacitors for use in electronic equipment-Part 21 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class1
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

CONTENTS

- 1. CODE CONSTRUCTION
- 2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE
- 3. OPERATING TEMPERATURE RANGE
- 4. STORING CONDITION AND TERM
- 5. P.C. BOARD
- 6. INDUSTRIAL WASTE DISPOSAL
- 7. PERFORMANCE
- 8. INSIDE STRUCTURE AND MATERIAL
- 9. CAUTION FOR PRODUCTS WITH SOFT TERMINATION
- 10. PACKAGING
- 11. RECOMMENDATION
- 12. SOLDERING CONDITION
- 13. CAUTION
- 14. TAPE PACKAGING SPECIFICATION

<EXPLANATORY NOTE>

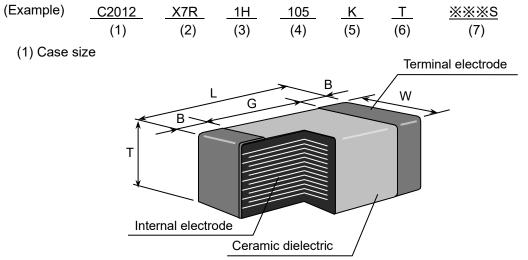
When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.			
Ceramic Capacitors Business Group	October, 2023	C-Soft-i			

1. CODE CONSTRUCTION



Туре	Dimensions (Unit : mm)							
TDK[EIA style]	L	W	Т	В	G			
C1005	1.00 ^{+0.15} - 0.05	0.50 ^{+0.10} - 0.05	0.50 ^{+0.10} - 0.05	0.10 min.	0.30 min.			
[CC0402]	1.00 ^{+0.25} _{-0.10} 0.50 ^{+0.20} _{-0.10}		0.50 ^{+0.20} - 0.10	0.10 1111.	0.00 mm.			
C1608 [CC0603]	1.60 ^{+0.20} - 0.10	0.80 ^{+0.15} - 0.10	0.80 ^{+0.15} - 0.10	0.20 min.	0.30 min.			
			0.60±0.15					
C2012	2.00 ^{+0.45} - 0.20	1.25 ^{+0.25} - 0.20	0.85±0.15	0.20 min.	0.50 min.			
[CC0805]	- 0.20	- 0.20	1.25 ^{+0.25} - 0.20					
			0.85±0.15					
C3216	o oo +0.40	+0.30	1.15±0.15		1.00 min.			
[CC1206]	3.20 ^{+0.40} - 0.20	1.60 ^{+0.30} - 0.20	1.30±0.20	0.20 min.				
			1.60 ^{+0.30} - 0.20					
	3.20 ^{+0.50} - 0.40	2.50±0.30	1.60 ^{+0.30} - 0.20	0.20 min.				
C3225 [CC1210]			2.00 ^{+0.30} - 0.20					
[001210]	- 0.40		2.30 ^{+0.30} - 0.20					
			2.50±0.30					
0.4500	. 0. 50		2.00 ^{+0.30} - 0.20					
C4532 [CC1812]	4.50 ^{+0.50} - 0.40	3.20±0.40	2.30 ^{+0.30} - 0.20	0.20 min.				
			2.50±0.30	•				
C5750	5.70 ^{+0.50} - 0.40	5.00±0.40	2.30 ^{+0.30} - 0.20	0.20 min.				
[CC2220]	- 0.40		2.50±0.30					
C7563	7.50±0.50	6.30±0.50	2.50 max.	0.30 min.				
[CC3025]	1.00±0.00	0.00±0.00	3.00 max.	5.00 mm.	l			

* As for each item, please refer to detail page on TDK web.

(2) Temperature Characteristics

* Details are shown in table 1 No.6 and No.7 at 7.PERFORMANCE

Symbol	Rated Voltage
2 J	DC 630 V
2 W	DC 450 V
2 E	DC 250 V
2 A	DC 100 V
1 H	DC 50 V

Symbol	Rated Voltage
1 V	DC 35 V
1 E	DC 25 V
1 C	DC 16 V
1 A	DC 10 V
0 J	DC 6.3 V

(4) Rated Capacitance

(5) Capacitance tolerance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

(Example)

Symbol	Rated Capacitance
105	1,000,000 pF

Symbol	Tolerance
J	± 5%
К	± 10 %
*M	± 20 %

(6) Packaging

* C1005 type is applicable to tape packaging only.

* M tolerance shall be standard for over 10uF.

Symbol	Packaging
В	Bulk
Т	Taping

(7) TDK internal code

<u>※※※</u> <u>S</u> S : Soft Termination

- These TDK internal codes are subject to change without notice.

2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Class	Temperature Characteristics	Capacitance tolerance	Rated capacitance
1	C0G	J (± 5%)	E – 12 series
2	X5R X7R X7S X7T X8R X8L	K (± 10 %) M (± 20 %)	E – 6 series

Capacitance Step in E series

E series	Capacitance Step											
E- 6	1.	.0	1.5 2.2			3.	.3	4.7		6.8		
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

3. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X5R	-55°C	85°C	25°C
C0G/X7R/X7S/X7T	-55°C	125°C	25°C
X8R/X8L	-55°C	150°C	25°C

4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

5. P.C. BOARD

When mounting on an aluminum substrate, the capacitors are more likely to be affected by heat stress from the substrate.

Please inquire separate specification when mounted on the substrate.

6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

7. PERFORMANCE

	Γ						
No.	Item	Performance		Test or inspection method			
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3×)			s (3×)	
2	Insulation Resistance	Please refer to detail page on TDK web.	Measuring voltage : Rated voltage (As for the capacitor of rated voltage 630V DC, apply 500V DC.) Voltage application time : 60s.				ed voltage .)
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.		volta RV≦ 100' RV≦ 100V <i 500' applicat</i 	ated ge(RV) ≦100V V <rv ≦100V RV≦500V V<rv tion time : rge curre</rv </rv 	3 1.5 2.5 1.5 1.3 1.3	Apply voltage × rated voltage 5 × rated voltage
4	Capacitance	Within the specified tolerance.	1000 ur Over (Class2 Capa 10uF at Over As for r	citance pF and nder 1000pF » citance nd under · 10uF neasurir	Measurii frequend 1MHz±10 1kHz±10 Measurii frequend 1kHz±10 120Hz±20 ng conditi epresenta	cy)% ng cy)% 0% ion,	Measuring voltage 0.5 - 5 Vrms. Measuring voltage 1.0±0.2Vrms 0.5±0.2Vrms. please contact
5	Q (Class1) Dissipation Factor (Class2)	Please refer to detail page on TDK web.	See No. condition		table for	mea	asuring
6	Temperature Characteristics of Capacitance (Class1)	T.C.Temperature CoefficientCOG $0 \pm 30 \text{ (ppm/°C)}$ Capacitance drift within $\pm 0.2\%$ or $\pm 0.05 \text{pF}$, whichever larger.	Temperature coefficient shall be calculated based on values at 25°C and 85°C temperature. Measuring temperature below 25°C shall b -10°C and -25°C.			l 85°C	

	unued)						
No.	Item		Performance		est or inspection method		
7	Temperature Characteristics of Capacitance		Capacitance Change (%)	steps sho	nce shall be measured by the wn in the following table after guilibrium is obtained for each		
	(Class2)		No voltage applied	thermal equilibrium is obtained for each step.			
			X5R : ± 15	ΔC be calculated ref. STEP3 reading			
			X7R : ± 15 X7S : ± 22	Step	Temperature(°C)		
			X7T : +22 - 33	1	Reference temp. ± 2		
			X8R : ± 15	2	Min. operating temp. ± 2		
			X8L : +15 - 40	3	Reference temp. ± 2		
			:	4	Max. operating temp. ± 2		
				Reference "3. OPERA As for me	n./Max. operating temp and e temp., please refer to ATING TEMPERATURE RANGE" asuring voltage, please contact ales representative.		
8	Robustness of Terminations				No sign of termination coming off, breakage of ceramic, or other abnormal signs.	P.C.Board Apply a pro- center of a direction of Pushing for (2N is app	older the capacitors on a d shown in Appendix 2. ushing force gradually at the a specimen in a horizontal of P.C.board. orce : 5N olied for C1005 type.) me : 10±1s.
					Pushing force P.C.Board		
9	Bending Exterr appea		No mechanical damage.	a P.C.Boa and bend	50 F R230 45 45 45 Bending		
					(Unit : mm)		

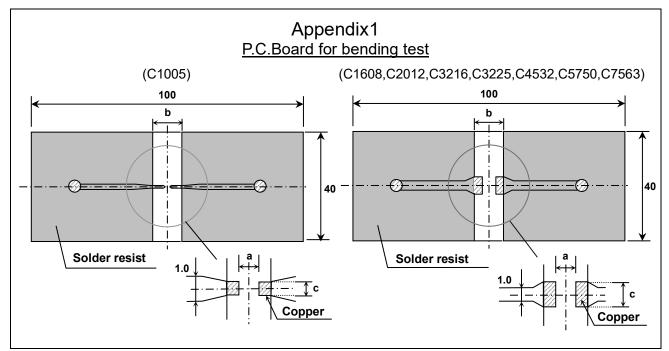
No.		em	Per	formance	Test or inspection method		
10	Solderability		Iderability New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections		Solder : Flux :	Sn-3.0Ag-0.5Cu Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
			shall not be ex		Solder temp. :	245±5°C	
			material.		Dwell time :	3±0.3s.	
				Ţ	Solder position :	Until both terminations are completely soaked.	
				A section			
11	Resistance to solder	External appearance		nall be covered at	Solder :	Sn-3.0Ag-0.5Cu	
	heat	Capacitance	least 60% with	Change from the	Flux :	Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.	
			Characteristic	value before test	Solder temp. :	260±5°C	
			X5R X7R		Dwell time :	10±1s.	
			Class2 X7S X7T X8R X8L	± 7.5 %	Solder position :	Until both terminations are completely soaked.	
		Q (Class1)	Meet the initial	spec.	Pre-heating :	Temp. — 110∼140°C Time — 30∼60s.	
		D.F. (Class2)	Meet the initial	spec.	Leave the capa condition for	citors in ambient	
		Insulation Resistance	Meet the initial	spec.	Class 1 : 6~24h Class 2 : 24±2h	ו before measurement.	
		Voltage proof	No insulation b other damage.				
12	Vibration	External appearance	No mechanica	damage.	Frequency : 10 Reciprocating)~55~10Hz sweep time : 1 min.	
		Capacitance	Characteristics	Change from the value before test	Amplitude : 1.5	•	
			Class1 COG	± 2.5 %	directions(Tota		
			Class2 X5R X7R X7S X7T X8R X8L	± 7.5 %		the capacitors on a wn in Appendix 2 before	
		Q (Class1)	Meet the initial	spec.			
		D.F. (Class2)	Meet the initial	spec.			

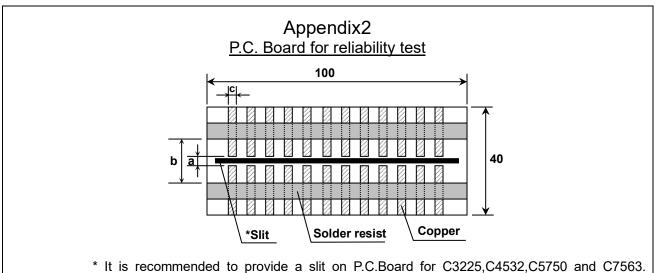
0.	lt	em	Performance		ormance	Test or inspection method			
13	Temperature cycle	External appearance Capacitance	No mechanical damage.		Expose the capacitors in the condition step1 through step 4 listed in the following table.				
			Class1	C0G	value before test		cycle : 5 cycles	1	
				X5R	Please contact	Step	Temperature(°C)	Time (min.)	
			Class2	X7R X7S X7T	with our sales representative.	1	Min. operating temp.±3	30 ± 3	
				X8R X8L		2	Ambient Temp.	2~5	
	Q Meet the initial spec.	3	Max. operating temp.±2	30 ± 2					
		(Class1)			·	4	Ambient Temp.	2~5	
		D.F. (Class2)	Meet the	initial	spec.	As for	Min./Max. operating	temp.,	
		Insulation Resistance	Meet the initial spec.			please refer to "3. OPERATING TEMPERATURE RANGE"			
		Voltage proof	No insula other dan		reakdown or	conditi Class Class Reflow	1 : 6~24h 2 : 24±2h before measurement. v solder the capacitors on a pard shown in Appendix2 before		
14	Moisture Resistance	External appearance	No mech	anical	damage.		Test temp. : 40±2°C		
	(Steady State)	Capacitance	Characte Class1 Class2	eristics COG X5R X7R X7R X7S X7T X8R X8L	Change from the value before test Please contact with our sales representative.	Test humidity : 90~95%RH Test time : 500 +24,0h Leave the capacitors in ambient condition for Leave the capacitors in ambient condition for Class 1 : 6~24h Class 2 : 24±2h before measurer Reflow solder the capacitors on a P.C.Board shown in Appendix2 b		bient	
		Q (Class1)	350 min.						
		D.F. (Class2)	200% of i	nitial s	spec. max.	testing			
		Insulation Resistance	Please co represent		with our sales	_			

No.	lt	em		Perfo	ormance	Test or inspection method
15	Moisture Resistance	External appearance	No mech	anical	damage.	Test temp. : 40±2°C Test humidity : 90~95%RH Applied voltage : Rated voltage
		Capacitance	Charact	eristics	Change from the value before test	Test time : 500 +24,0h Charge/discharge current : 50mA or lower
			Class1	C0G X5R		Leave the capacitors in ambient condition for
			Class2	X7R X7S X7T	Please contact with our sales representative.	Class 1 : 6~24h Class 2 : 24±2h before measurement.
				X8R X8L		Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.
		Q (Class1)	200 min.			Initial value setting (only for class 2)
		D.F. (Class2)	200% of i	initial s	pec. max.	 Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the
		Insulation Resistance	Please co represent		with our sales	capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.
16	Life	ife External appearance		anical	damage.	Test temp. : Maximum operating temperature±2°C
		Capacitance	Characteristics Change from the		Change from the value before test	Applied voltage : Please contact with our sales representative.
			Class1	C0G		Test time : 1,000 +48,0h
				X5R	Please contact	Charge/discharge current : 50mA or lower Leave the capacitors in ambient
				X7R X7S	with our sales	condition for
			Class2	X7T	representative.	Class 1 : 6~24h
				X8R X8L		Class 2 : 24±2h before measurement.
		Q (Class1)	350 min.			Reflow solder the capacitors on a P.C.Board shown in Appendix2 before
		D.F. (Class2)	200% of i	initial s	pec. max.	testing.
		Insulation			with our sales	Initial value setting (only for class 2)
		Resistance		representative.		Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement.
						Use this measurement for initial value.

*As for the initial measurement of capacitors (Class2) on number 7,11,12,13 and 14 leave capacitors at $150 -10,0^{\circ}$ C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.

GC110G0014





		(Un	it : mm)
Symbol Case size	а	b	с
C1005 [CC0402]	0.4	1.5	0.5
C1608 [CC0603]	1.0	3.0	1.2
C2012 [CC0805]	1.2	4.0	1.65
C3216 [CC1206]	2.2	5.0	2.0
C3225 [CC1210]	2.2	5.0	2.9
C4532 [CC1812]	3.5	7.0	3.7
C5750 [CC2220]	4.5	8.0	5.6
C7563 [CC3025]	5.5	9.1	6.9

1. Material : Glass Epoxy(As per JIS C6484 GE4)

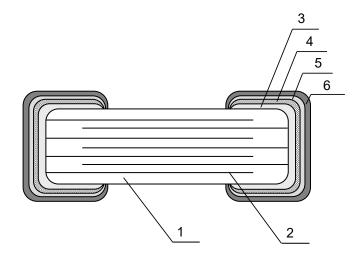
2. Thickness : Appendix 1 — 0.8mm (C1005) — 1.6mm (C1608,0

(C1608,C2012,C3216,C3225,C4532,C5750,C7563)

: Appendix 2 — 1.6mm

Copper(Thickness:0.035mm) Solder resist

8. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL		
NO.	NAME	Class1	Class2	
1	Dielectric	CaZrO₃	BaTiO₃	
2	Electrode	Nickel (Ni)		
3		Copper (Cu)		
4	Termination	Conductive resin (Filler : Ag)		
5	Termination	Nickel (Ni)		
6		Tin	(Sn)	

9. CAUTION FOR PRODUCTS WITH SOFT TERMINATION

This product contains Ag (Silver) as part of the middle layer of termination. To avoid electromigration of Ag under high temperature and humidity, and failures caused by corrosive gas, chip capacitors on P.C boards should be protected by moisture proof-sealing.

10. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

10.1 Each plastic bag for bulk packaging contains 1000pcs. And the minimum quantity for Bulk packaging is 1000pcs.

10.2 Tape packaging is as per 14. TAPE PACKAGING SPECIFICATION

.*C1005[CC0402] type is applicable to tape packaging only.

1) Inspection No.*

- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F} \ \underline{3} \ \underline{A} \ - \ \underline{23} \ - \ \underline{001}$$

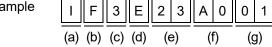
(a) (b) (c) (d) (e)

(a) Line code

- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- e) Serial No. of the day

*Composition of new Inspection No. (Implemented on and after May 1, 2019 in sequence)

Example



- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)

(e) Inspection Date of the month.

- (f) Serial No. of the day($00 \sim ZZ$)
- (g) Suffix(00 \sim ZZ)

*It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases.

Until the shift is completed, either current or new composition of inspection No. will be applied.

11. RECOMMENDATION

As for C3225 [CC1210] and larger, It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

12. SOLDERING CONDITION

As for C1005[CC0402], C3225[CC1210] and larger, reflow soldering only. For other case sizes than the above, reflow soldering is recommended.

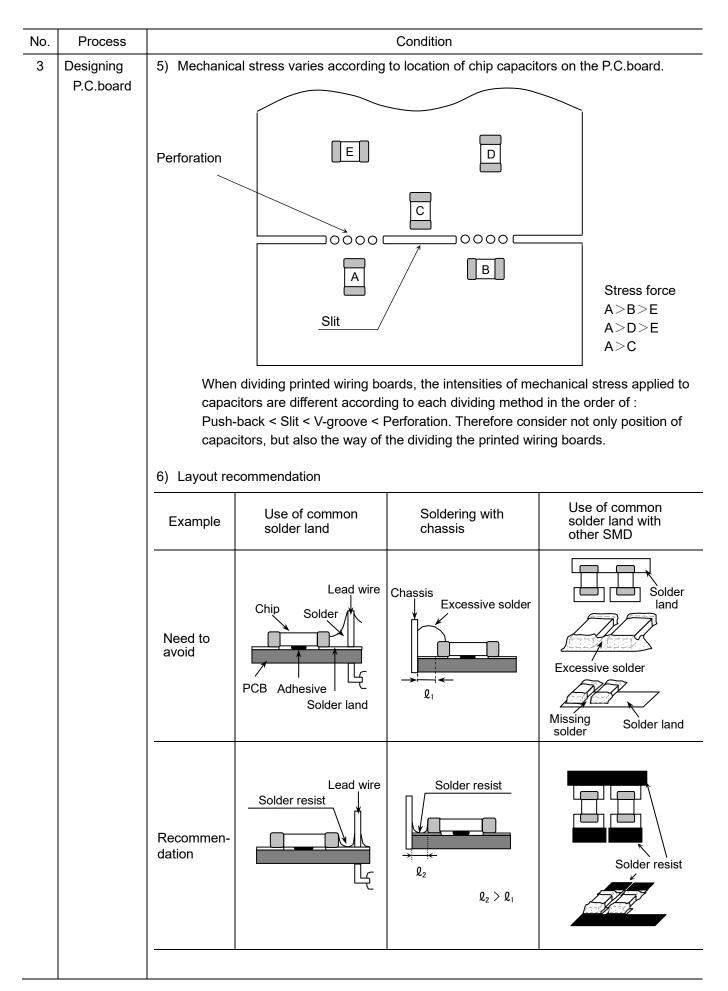
13. CAUTION

No.	Process	Condition
1	Operating Condition (Storage, Use,	 1-1. Storage, Use The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.
	Transportation)	 High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		 2) When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term.
		 Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		 4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		 1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design	2-1. Operating temperature
_	<u>/</u> Caution	 Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.
		 Surface temperature including self heating should be below maximum operating temperature.
		Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme.
		Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board material and the design, etc.
		The load should be contained so that the self-heating temperature rise of the capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C. When using in a high-frequency circuit or a circuit in which a capacitor generates
		heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural convection such as a cooling fan.)
		 The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.

No.	Process	Condition
2	Circuit design	 2-2. When overvoltage is applied Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature. 2-3. Operating voltage Operating voltage Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. — (1) and (2) AC or pulse with overshooting, V_{P-P} must be below the rated voltage. — (3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage
		Positional Measurement (Rated voltage)
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)
		$\begin{array}{c c c c c c c c c c c c c c c c c c c $
		 2) Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.
		 The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.
		 Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated voltage.
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.
		2-4. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.

No.	Process	Condition							
3	Designing	The amount of sold capacitors.	ler at the termina	itions has a direc	ct effect on the re	liability of the			
	P.C.board		kely that it will br	eak. When desig	stress on the ch ning a P.C.board er amount of sold	, determine the			
		2) Avoid using cor solder land for e	nmon solder lan each termination		minations and pro	ovide individual			
		3) Size and recom	nmended land di	mensions.					
			Ch	p capacitors So	older land				
					Sol	der resist			
		Reflow soldering				(Unit : mm			
		Case size Symbol	C1005 [CC0402]	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC1206]			
		A	0.3 ~ 0.5	0.6 ~ 0.8	0.9 ~ 1.2	2.0 ~ 2.4			
		В	0.35 ~ 0.45	0.6 ~ 0.8	0.7 ~ 0.9	1.0 ~ 1.2			
		С	0.4 ~ 0.6	0.6 ~ 0.8	0.9 ~ 1.2	1.1 ~ 1.6			
		Case size Symbol	C3225 [CC1210]	C4532 [CC1812]	C5750 [CC2220]	C7563 [CC3025]			
		A	2.0 ~ 2.4	3.1 ~ 3.7	4.1 ~ 4.8	5.2 ~ 5.8			
				10.11	1.2 ~ 1.4	1.7 ~ 1.9			
		В	1.0 ~ 1.2	1.2 ~ 1.4	1.2~1.4				
		В С	1.0 ~ 1.2 1.9 ~ 2.5	2.4 ~ 3.2	4.0 ~ 5.0	6.4 ~ 7.4			
			1.9 ~ 2.5						
		C	1.9 ~ 2.5		4.0 ~ 5.0				
		C Flow soldering (U Case size	1.9 ~ 2.5 Jnrecommend) C1608	2.4 ~ 3.2 C2012	4.0 ~ 5.0 (Unit : mm) C3216				
		C Flow soldering (U Case size Symbol	1.9 ~ 2.5 Jnrecommend) C1608 [CC0603]	2.4 ~ 3.2 C2012 [CC0805]	4.0 ~ 5.0 (Unit : mm) C3216 [CC1206]				

No.	Process		Condition	
3	Designing P.C.board	4) Recommende	d chip capacitors layout is as follo	owing.
			Disadvantage against bending stress	Advantage against bending stress
		Mounting face	Perforation or slit	Perforation or slit
			Break P.C.board with mounted side up.	Break P.C.board with mounted side down.
			Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit
		Chip arrangement (Direction)	Perforation or slit	Perforation or slit
			Closer to slit is higher stress	Away from slit is less stress
		Distance fron slit	$(\mathcal{Q}_1 < \mathcal{Q}_2)$	$\begin{array}{c c} & & & & \\ & & & & \\ & & & & \\ & & & & $



No.	Process			Condition				
4	Mounting	 4-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitors to result in cracking. Please take following precautions. 1) Adjust the bottom dead center of the mounting head to reach on the P.C.board surface and not press it. 						
				pressure to be 1 to 3N	-			
		support from the	 3) To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. See following examples. 					
			Not	recommended	Recommended			
	Single-sided mounting Double-sides mounting			Crack	A support pin is not to be underneath the capacitor.			
		Double-sides mounting	Solde	r g Crack	Support pin			
		When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it. 4-2. Amount of adhesive						
					b			
			Example :	C2012 [CC0805], C3	216 [CC1206]			
		-	a	0.2mm m				
		-	b	70 ~ 100µ	ım			
		-	С	Do not touch the	solder land			

No.	Process		Condition			
5	Soldering	 5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm the following to select the appropriate flux. 1) It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. 				
		2) Excessive flux must be av		e proper amount of flux.		
		3) When water-soluble flux is	•			
		5-2. Recommended soldering	profile : Reflow metho	bd		
		Refer to the following temperature profile at Reflow soldering. Reflow soldering Soldering Preheating Vatural cooling Preheating Vatural cooling O g O g O ver 60 sec. Peak Temp time Reflow soldering is recommended for C1608,C2012,C3216 types, but only reflow soldering is allowed for other case sizes. 5-3. Recommended soldering peak temp and peak temp duration for Reflow soldering				
		Temp./Duration	Reflow so	Idering		
		Solder	Peak temp(°C)	Duration(sec.)		
		Lead Free Solder	260 max.	10 max.		
		Sn-Pb Solder	230 max.	20 max.		
		Recommended solder con Lead Free Solder : Sn-3.	•			

Process	Condition					
Soldering	5-4. Soldering profile : Flow method (Unrecommend) Refer to the following temperature profile at Flow soldering.					
		Flow soldering				
		Preheating Soldering Natural of	ooling			
	←	→ * *	>			
	Peak Temp					
	Q i i i i i i i i i i i i i					
	Reflow soldering is recommended for C1608,C2012,C3216 types.					
	Pb free solder is recomm	ended, but if Sn-37Pb mu	•			
	Temp./Dura	ation Flow s	oldering			
	Solder	Peak temp(°C)	Duration(sec.)			
	Lead Free Sol	der 260 max.	5 max.			
	Sn-Pb Solder	250 max.	3 max.			
	Recommended solder compositions Lead Free Solder : Sn-3.0Ag-0.5Cu					
	5-6. Avoiding thermal shock	K				
	1) Preheating condition	1				
	Soldering	Case size		ıp. (°C)		
	Defleux eeldering			≦ 150		
	Reliow soldering	C3225[CC1210], C4532[CC1812],		≦ 130		
	Flow soldering		C08051	≦ 150		
	Soldering	Refer to the following tent Refer to the following tent Peak G G G G G G G G C C C C C C C C C C C C C	Refer to the following temperature profile at Flow so Flow soldering Preheating Soldering Natural of Peak Temp Units Reflow soldering is recommended for C1608,C2013 5-5. Recommended soldering peak temp and peak temp Peak Temp Units Solder Peak temp (°C) Lead Free Solder 260 max. Sn-Pb Solder 250 max. Recommended solder compositions Lead Free Solder : Sn-3.0Ag-0.5Cu 5-6. Avoiding thermal shock 1) Preheating condition Soldering Case size Reflow soldering Case s	Refer to the following temperature profile at Flow soldering. Flow soldering Preheating Soldering Natural cooling Preheating Soldering Natural cooling Over 60 sec. Over 60 sec. Over 60 sec. Over 60 sec. Peak Temp time Reflow soldering is recommended for C1608,C2012,C3216 types. S-5. Recommended soldering peak temp and peak temp duration for Fh Pb free solder is recommended, but if Sn-37Pb must be used, refer to Our temp./Duration Flow soldering Solder Soldering Soldering Soldering <t< td=""></t<>		

No.	Process	Condition					
5	Soldering	5-7. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.					
		Excessive solder Higher tensile force in chip capacitors to cause crack					
		Adequate					
	5-	Insufficient solder Low robustness may cause contact failure or chip capacitors come off the P.C.board.					
		 5-8. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-9. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative) Recommendations to prevent the tombstone phenomenon) 					

Process	Condition					
Solder repairing	 6-1. Solder repair by solder iron 1) Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C.board material and solder land size. The higher the tip temperature, the quicker the operation. However, heat shock may cause a crack in the chip capacitors. Please make sure the tip temp. before soldering and keep the peak temp and time in accordance with following recommended condition. 					
	Case size			Duration (sec.)	Wattage (W	<u>, </u>
	C1005[CC0402] C1608[CC0603] C2012[CC0805] C3216[CC1206] C3225[CC1210] C4532[CC1812] 280 max					ø3.0 max.
 C7563[CC3025] * Please preheat the chip capacitors with the condition in 6-2 to ave thermal shock. 2) Direct contact of the soldering iron with ceramic dielectric of chip cause crack. Do not touch the ceramic dielectric and the terminal shock. 						chip capacitors may
	 3) It is not recommended to reuse dismounted capacitors. 6-2. Avoiding thermal shock Preheating condition 					
		-		CC0402], C1608[C0		$\Delta T \leq 150$
	Manual solde	ering				$\Delta T \leq 130$
		Solder repairing is una 6-1. Solder repairing is una 6-1. Solder repair by s 1) Selection of the sa Tip temperature land size. The hi However, heat si Please make suittime in accordan F T Recommended Case size C1005[CC0402] C1608[CC0603] C2012[CC0805] C3216[CC1206] C3226[CC1210] C4532[CC1812] C5750[CC2220] C7563[CC3025] * Please preheat t thermal shock. 2) Direct contact of cause crack. Do iron. 3) It is not recomm 6-2. Avoiding thermal Preheating condit Soldering	Solder repairing Solder repairing is unavoida 6-1. Solder repair by solder 1) Selection of the solderin Tip temperature of sold Individual size. The higher the However, heat shock in Please make sure the stime in accordance with the interval shock. Solder repairing is unavoid a field with the interval shock. 20 Direct contact of the sc cause crack. Do not to iron. 3) It is not recommended 6-2. Avoiding thermal shock	Solder repairing is unavoidable, refe 6-1. Solder repair by solder iron 1) Selection of the soldering iron til Tip temperature of solder iron on land size. The higher the tip temperature of solder iron on land size. The higher the tip temperature in accordance with following please make sure the tip temperature in accordance with following of the solder iron constraints of the solder iron constraints. Recommended solder iron constraints. Constraints. Constore the soldering constraints. C	Solder repairing Solder repairing is unavoidable, refer to below. 6-1. Solder repair by solder iron 1) Selection of the soldering iron tip Tip temperature of solder iron varies by its type, land size. The higher the tip temperature, the qu However, heat shock may cause a crack in the c Please make sure the tip temp. before soldering time in accordance with following recommended Manual soldering (Solder iron) (Solder iron)	Solder repairing Solder repairing is unavoidable, refer to below. 6-1. Solder repair by solder iron 1) Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C.board m land size. The higher the tip temperature, the quicker the ope However, heat shock may cause a crack in the chip capacito Please make sure the tip temp. before soldering and keep th time in accordance with following recommended condition. Manual soldering (Solder iron) Please make sure the tip temp. before soldering (Solder iron) Paix (Solder iron) Paix (Solder iron) Paix (Solder iron) (Solder iron) Paix (Solder iron) Paix (Solder iron) (Solder iron)<

No.	Process	Condition
7	Cleaning	1) If an unsuitable cleaning fluid is used, flux residue or some foreign articles may
		stick to chip capacitors surface to deteriorate especially the insulation resistance
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing
		(1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems(1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/lmax.
		Frequency : 40 kHz max.
		Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may
		bring the same result as insufficient cleaning.

No.	Process		Condition						
8	Coating and molding of the P.C.board	 This product contains Ag (Silver) as part of the middle layer of terminatic To avoid electromigration of Ag under high temperature and humidity, and caused by corrosive gas, chip capacitors on P.C boards should be prote moisture proof-sealing. When the P.C.board is coated, please verify the quality influence on the 							
		 Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors. 							
		4) Please verify the curir	ng temperature.						
9	Handling after chip mounted Caution	,	not to bend or distort the P.C the chip capacitors may cra nd	-					
		proper tooling. Printed cropping jig as shown prevent inducing med (1)Example of a boar Recommended ex close to the croppi the capacitor is co Unrecommended e the pushing directi	a circuit board cropping shoul in in the following figure or a hanical stress on the board. Ind cropping jig cample: The board should be ng jig so that the board is not mpressive. example: If the pushing point	d out by hand, but by using the d be carried out using a board a board cropping apparatus to e pushed from the back side, t bent and the stress applied to is far from the cropping jig and be board, large tensile stress is ks.					
		Outline of jig Printed circuit board v-groove Board Slot	Recommended	Unrecommended Load point Printed circuit board V-groove					

No.	Process		Condition						
9	Handling after chip mounted <u>(</u> Caution	 (2)Example of a board cropping machine An outline of a printed circuit board cropping machine is shown below. The top and bottom blades are aligned with one another along the lines with the V-grooves on printed circuit board when cropping the board. Unrecommended example: Misalignment of blade position between top and bottom, right and left, or front and rear blades may cause a crack in the capacitor. 							
		ted circuit board	Top blade						
					Cro Printed circuit t		am op blade		
			Recommended	Unrecommended					
				Top-bottom misalignment	Left-right misalignment	Front-rear misalignment			
			Top blade Board Board Bottom blade	Top blade	Top blade	Top blade			
		to be adju and bend	nctional check of usted higher for f the P.C.board, it ons off. Please ad	ear of loose con t may crack the o	tact. But if the chip capacitor	e pressure is ex rs or peel the	cessive		
		Item	Not recor	nmended	Re	commended			
		Board bending	Board Termination				pin 		

No.	Process	Condition
10	Handling of loose chip capacitors	 If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care.
		2) Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack.
11	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
12	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient : 3 multiplication rule, Temperature acceleration coefficient : 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

No.	Process	Condition
13	Caution during operation of equipment	 A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit
		 3) Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. (1) Environment where a capacitor is spattered with water or oil (2) Environment where a capacitor is exposed to direct sunlight (3) Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation (4) Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) (5) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. (6) Atmosphere change with causes condensation
14	Others	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) and automotive application under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (electric trains, ships, etc. except automotive application) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment
		(13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.

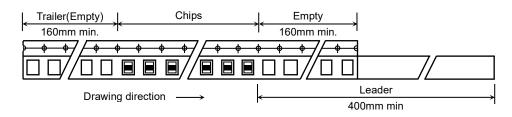
14. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4. Dimensions of plastic tape shall be according to Appendix 5, 6.

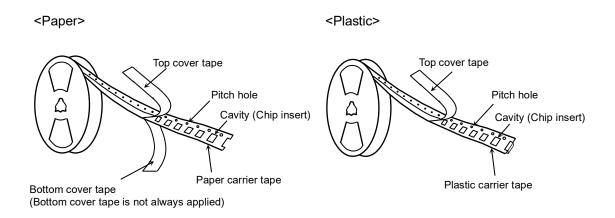
1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of \emptyset 178 reel shall be according to Appendix 7, 8. Dimensions of \emptyset 330 reel shall be according to Appendix 9, 10.

1-4. Structure of taping

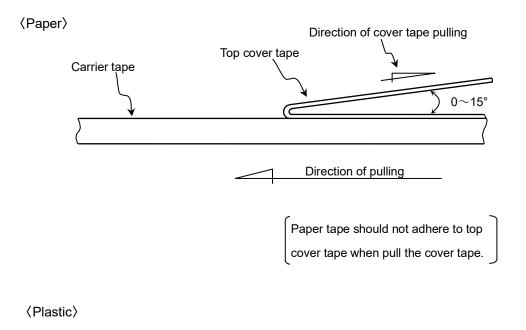


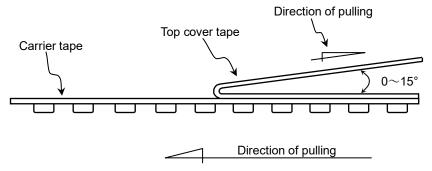
2. CHIP QUANTITY

Please refer to detail page on TDK web.

3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape) 0.05N < Peeling strength < 0.7N

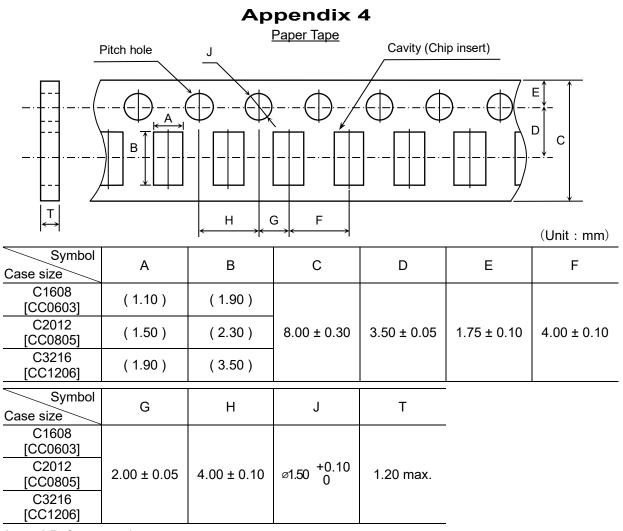




- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

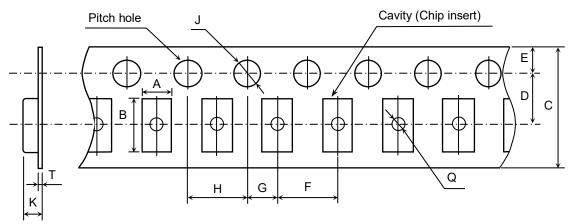
Paper Tape							
	Pitch hole	J	isert)				
						C (Unit : mm)	
Symbol Case size	А	В	С	D	E	F	
C1005 [CC0402]	(0.65)	(1.15)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	2.00 ± 0.05	
Symbol Case size	G	Н	J	Т			
C1005 [CC0402]	2.00 ± 0.05	4.00 ± 0.10	ø1.50 +0.10 0	0.75 max.			
() Reference value.							

() Reference value. * Applied to thickness, 0.50 +0.20,-0.10mm products.



() Reference value.

Plastic Tape



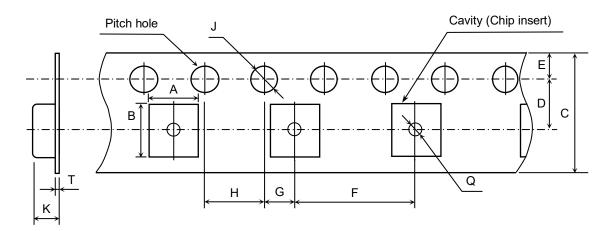
(Unit : mm)

Symbol Case size	А	В	С	D	E	F
C2012 [CC0805]	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05		
C3216 [CC1206]	(1.90)	(3.50)	0.00 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3225 [CC1210]	(2.90)	(3.60)	8.00 ± 0.30 or 12.00 ± 0.30	3.50 ± 0.05 or 5.50 ± 0.05		
Symbol Type	G	Н	J	К	Т	Q
C2012 [CC0805] C3216 [CC1206]	2.00 ± 0.05	4.00 ± 0.10	ø1.50 +0.10 0	2.50 max.	0.60 max.	ø0.50 min.
C3225 [CC1210]				3.40 max.		

() Reference value.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

Plastic Tape

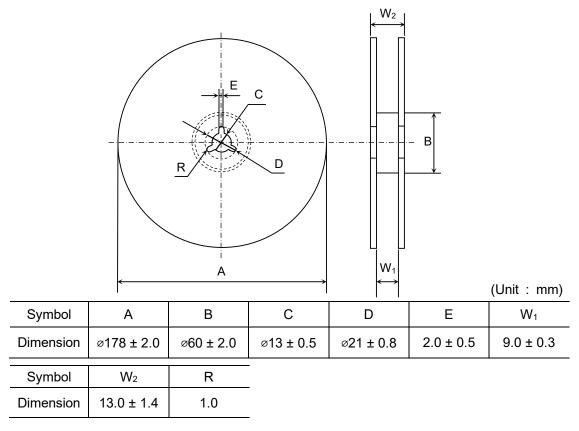


						(Unit : mm)
Symbol Case size	А	В	С	D	Е	F
C4532 [CC1812]	(3.60)	(4.90)	12.00 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
C5750 [CC2220]	(5.40)	(6.10)				
C7563 [CC3025]	(6.90)	(8.00)	16.00 ± 0.30	7.50 ± 0.05		12.00 ± 0.10
Symbol Case size	G	Н	J	к	Т	Q
C4532 [CC1812]	2.00 ± 0.05 2.00 ± 0.10	4.00 ± 0.10	ø1.50 +0.10 0	6.50 max.	0.60 max.	ø1.50 min.
C5750 [CC2220]						
C7563 [CC3025]				5.00 max.		

() Reference value.

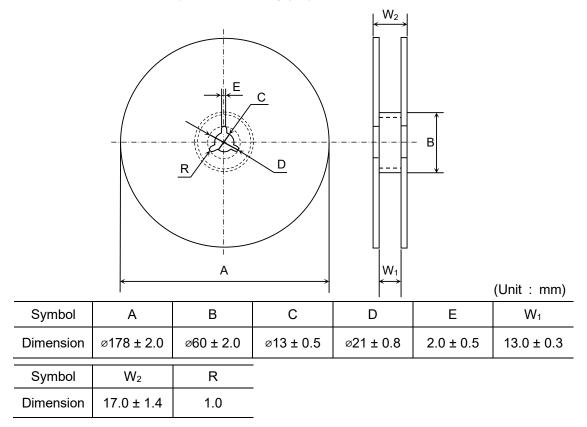
Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225(8mm width taping type)

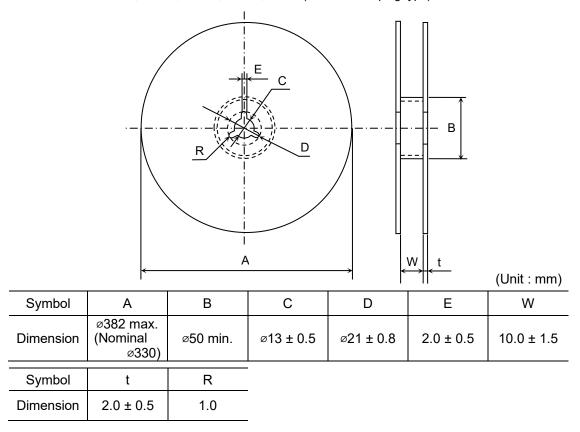


Appendix 8

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(12mm width taping type), C4532, C5750



<u>Dimensions of reel</u> (Material : Polystyrene) C1005, C1608, C2012, C3216, C3225(8mm width taping type)



Appendix 10

<u>Dimensions of reel</u> (Material : Polystyrene) C3225(12mm width taping type), C4532, C5750, C7563

03223(12hin wut taping type), 04332, 03730, 07303						
		R	E C			(Unit : mm)
Symbol	А	В	С	D	E	W
Dimension	ø382 max. (Nominal ø330)	ø50 min.	ø13 ± 0.5	ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5 *17.5 ± 1.5
Symbol	t	R				
Dimension	2.0 ± 0.5	1.0	-			
* Applied to C	7563	•	•			

* Applied to C7563.